NODE-DISPLACEMENT METHOD IN THE CASE MEASUREMENT OF RELATIVE PERMITTIVITY OF AN OPEN CIRCUIT OF WATER BY THE

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 $arepsilon'(\lambda_0)$ in the X-band can be used to determine the relaxation time when the values of arepsilonan open circuit. Water is investigated at (2.5 $\leq \lambda_0 \leq 3.5$ cm). The experimental graph expression — $\lg(eta_b b)/eta_b d$, where the shifts are measured for two dielectric thicknesses in and tg δ for dielectrics with $1 \le \varepsilon' \le 95$ and $0 \le \text{tg } \delta \le 1$ can be calculated by means of the A simple method for measuring the complex permittivity is described. The values of ϵ'

ИЗМЕРЕНИЕ ОТНОСИТЕЛЬНОЙ КОМІГЛЕКСНОЙ ДИЭЛЕКТРИЧЕСКОЙ ПРОНИЦАЕМОСТИ ВОДЫ ПРИ ПОМОЩИ МЕТОЛА СМЕЩЕНИЯ УЗЛА В СЛУЧАЕ НЕЗАМКНУТОГО КОНТУРА

данных для $\epsilon'(\lambda_0)$ в диапазоне X позволяет определить время релаксации при ницаемости воды. Показано, что значения ε' ($1 \le \varepsilon' \le 95$) и $tg \ \delta \le 1$ можно определить на основе экспериментально измеренных величин сдвигов $tg \ (eta_o l_2)/eta_o d$ для волн с длиной из интервала 2,5 \leqslant λ_o \leqslant 3,5 cm. График экспериментальных для двух толщин диэлектрика в незамкнутом контуре. Исследования проводились В работе описан простой метод измерения комплексной диэлектрической про-

I. INTRODUCTION

exist in the precise selection of a waveguide method, which uses values of VSWR to constant α and hence for the values of ε' and ε'' . This means that some difficulties of information about the values of the phase constant β and the attenuation is not convenient to use the voltage standing wave ratio (VSWR = K_2) as a source an comparatively large value of $\varepsilon'(\varepsilon' \ge 50)$ is investigated. Obviously in this case it plane z = 0 (Fig. 1) is approximately equal to unity $(|\dot{\Gamma}_2| \approx 1)$ when the dielectric of It is known [1] that the magnitude of the complex reflection coefficient $\dot{\Gamma}_2$ in the

a function of frequency. of dielectric dispersion data, when it is necessary to obtain values of ε' and ε'' as calculate ε' and ε'' [1, 9]. Of course, such a problem appears mostly in the analysis

wavelength and the dielectric thickness d. described in [5] has a simple application in the case of investigating a fixed shift [5, 10-12]. The methods in [10-12] deal with low-loss dielectric and that values of arepsilon' and arepsilon'' [1, 2] and the other deals only with the standing wave minimum categories. One of them deals with VSWR and the minimum shift in order to obtain It is also worth noting that the existing waveguide methods generally fall into two

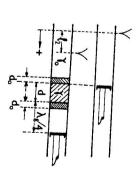


Fig. 1. Measurement of the shift t_2 for a dielectric sample in an open circuit, and $d_0 = 0.003$ cm.

stimulated the work reported here. of determining the values of $\varepsilon'(\omega)$ and $\varepsilon''(\omega)$ for a wide frequency band by measuring the shifts of the standing wave minimum. Indeed, this possibility According to the previous consideration it is useful to investigate the possibility

combination with the open circuit measurement are given briefly in the Appendix. thicknesses measured in an open circuit. The short circuit measurement and the described, using values of standing wave minimum shifts for two dielectric In the present paper a method for determining $\varepsilon'(\omega)$ and $\varepsilon''(\omega)$ in the X-band is

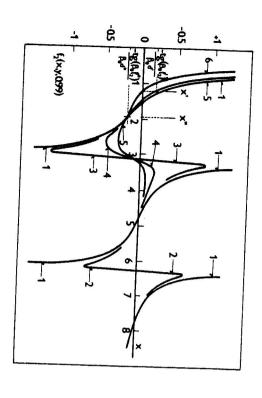
general cases I should be explicitly noted that the method described below can be used in two

- functions of ω . a) The investigation of dielectric dispersion data ($\lambda_0 \neq \text{const.}$) when ε' and ε'' are
- $0 \le \operatorname{tg} \delta \le 1$. b) The investigation at a given wavelength ($\lambda_0 = \text{const.}$) when $1 \le \varepsilon' \le 90$ and

II. METHOD

and l_2'' (Fig. 1). The values of ε' and ε'' are calculated by the equations [2] in an open circuit and on the measurement of the standing wave minimum shifts l_2^\prime The method is based on the investigation of two dielectric thicknesses d' and d''

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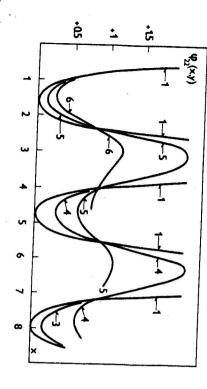


Fig. 2. Function $\varphi_{22}(x, y)$ and $f_2(x, y, 0.09)$ for $0 \le x \le 8$ and 1 - y = 0; 2 - y = 0.02; 3 - y = 0.05; 4 - y = 0.13; 5 - y = 0.23; 6 - y = 0.4.

$$\varepsilon' = \left[1 + (\beta^2 - \alpha^2) \left(\lambda_c/2\pi\right)^2\right] / \left[1 + (\lambda_c/\lambda_o)^2\right],\tag{1}$$

$$\varepsilon'' = \left[\frac{2\alpha\beta(\lambda_c/2\pi)^2}{[1 + (\lambda_c/\lambda_o)^2]} \right],$$

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where λ_c is the cut-off wavelength, λ_g is the waveguide wavelength $\gamma = \alpha + j\beta$ is the propagation constant in the liquid, $\gamma_0 = j\beta_0 = j2\pi/\lambda_g$ is the propagation constant in the empty waveguide (Fig. 1).

In eqs. (1) and (2) the phase constant β and the attenuation constant α are calculated with the help of the quantities $x(x=\beta d)$ and $y(y=\alpha/\beta)$.

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The necessary quantities x and y are obtained by the experimentally determined values of d and l_2 , using the expression

$$\frac{-\operatorname{tg}(\beta_0 l_2)}{\beta_0 d} = f_2(x, y, \beta_0 / \beta) .$$

(3)

In Eq. (3) $l_2(x, y, \beta_0/\beta)$ is given by [5]

$$l_2 = \frac{1}{2\beta_0} \arctan \frac{2(\beta_0/\beta) \varphi_2(x, y)}{1 - (\beta_0/\beta)^2 \varphi_{22}(x, y)},$$
(4)

$$\varphi_2(x, y) = \frac{(y \sinh 2xy - \sin 2x)}{(1+y^2)(\cosh 2xy - \cos 2x)},$$
 (5)

$$\varphi_{22}(x, y) = \frac{(\operatorname{ch} 2xy + \cos 2x)}{(1+y^2)(\operatorname{ch} 2xy - \cos 2x)}.$$
 (6)

The theoretical values of the function $f_2(x, y, \beta_0/\beta)$ in Eq. (3), (Fig. 2) are calculated by a computer.

The quantity β_0/β in Eq. (4) and in the function $f_2(x, y, \beta_0/\beta)$ Eq. (3) is taken as a constant and can be determined from the expression

$$(\beta/\beta_0)^4 + (\beta/\beta_0)^2 [(\lambda_g/\lambda_c)^2 - (\lambda_g/\lambda_0)^2 \varepsilon'] - [(\lambda_g/\lambda_0)^2 (\varepsilon''/2)]^2 = 0,$$
(7)

where λ_0 is the free-space wavelength and $(\lambda_u/\lambda_0)^2 = 1/[1 - (\lambda_0/\lambda_c)^2]$. The relation (7) is obtained easily from Eq. (1) and (2)

The relation (7) is obtained easily from Eqs. (1) and (2). The solution of (7) is

$$(\beta_0/\beta) = A(\lambda_0/\lambda_0) (\varepsilon')^{1/2},$$

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when $\epsilon' \ge 50$ and $(\lambda_g/\lambda_c)^2 \ll (\lambda_g/\lambda_0)^2 \epsilon'$.

Note that for $\operatorname{tg} \delta = 0$, $A = [(1 + \sqrt{1 + \operatorname{tg}^2 \delta})/2]^{1/2} = 1$, and for $\operatorname{tg} \delta = 1$, A = 1.098, which shows little dependence of the quantity (β/β_0) on $\operatorname{tg} \delta(0 \le \operatorname{tg} \delta \le 1)$. The results in Table 1 are derived from Eq. (7) for the X-band $(2.5 \le \lambda_0 \le 3.5 \text{ cm})$, appropriate value of ε' is known [2—4]. For example, in the analysis of dielectric dispersion data of water in the X-band, it is convenient to use $\beta_0/\beta = 0.09$ in the in conformity with Eq. (7), because the values of λ_0/λ_0 , ε' , and $\operatorname{tg} \delta = \varepsilon''/\varepsilon'$ are $\varepsilon'(1 \le \varepsilon' \le 95)$ and $\operatorname{tg} \delta(0 \le \operatorname{tg} \delta \le 1)$ is less than 0.2 % provided β_0/β in Eqs. (3) and (4) is taken from Table 1 and

$$|\operatorname{tg}(\beta_0 l_2)/\beta_0 d| \leq 1. \tag{9}$$

derived from Eqs. (3-6) $f_2(x, y, \beta_0/\beta)$ on the quantity β_0/β . For example, when tg $\delta = 0(y=0)$ it is easily The systematical error of 0.2 % is due to little dependence of the function

$$f_2(x, 0, \beta_0/\beta) = \cot g x/x$$
, (10)

of condition (9). which shows the independence of $f_2(x, 0, \beta_0/\beta)$ from the values of β_0/β , regardless

The values of β / β in the case of $0 \le tg \delta \le 1$ Table 1 1≤€'≤3

0.09 0.15 0.1 0.2 0.3 0.55 75≤€'≤95 60≤ε'≤75 40≤ε′≤60 20≤ε′≤40 $10 \leq \varepsilon' \leq 20$ 3≤ε′≤6 5≤ε'≤12 2≤€′≤4

the condition (9) and Eq. (3), in the following forms values of (β_0/β) . In this case the theoretical function $f_2(x, y, \beta_0/\beta)$ is written under Suppose that in Eqs. (3) and (4) two different constants a_1 and a_2 are used as

$$f_2'(x, y, a_1) = \frac{1}{\beta_0 d} \operatorname{tg} \left[\frac{1}{2} \arctan \left(\frac{2a_1 \varphi_2(x, y)}{1 - a_1^2 \varphi_{22}(x, y)} \right) \right] \leq 1,$$
 (11)

$$f_2''(x, y, a_2) = \frac{1}{\beta_0 d} \operatorname{tg} \left[\frac{1}{2} \operatorname{arctg} \frac{2a_2 \varphi_2(x, y)}{1 - a_2^2 \varphi_{22}(x, y)} \right] \le 1.$$
 (12)

excluding the case $(\beta_0/\beta)^2 \varphi_{22}(x, y) \approx 1$, the following approximate equation is valid Eqs. (11) and (12). Dividing Eq. (11) by Eq. (12) under the condition (9), The independence of $f_2(x, y, \beta_0/\beta)$ from the values of β_0/β can be proved from

$$\frac{f_2'(x, y, a_1)}{f_2''(x, y, a_2)} \simeq \frac{1 - a_1^2 \varphi_{22}(x, y)}{1 - a_1^2 \varphi_{22}(x, y)}.$$
(13)

approximately equal to unity, excluding the case $\varphi_{22}(x, y) \simeq 1/a_1^2$ (Fig. 2). When $\varepsilon' \ge 50$, Eq. (8) gives $(\beta_0/\beta)^2 \le 1$ and hence the expression (13) is

small (Fig. 2). Note that the region of x for which $f_2(x, y, \beta_0/\beta)$ depends on the β_0/β is very

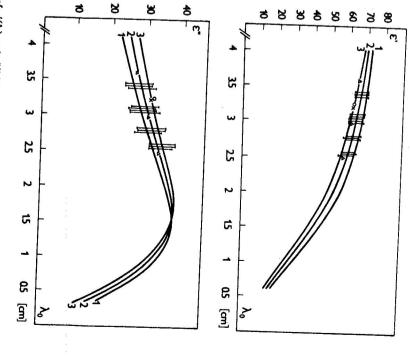


Fig. 3. Values of $\varepsilon'(\lambda_0)$ and $\varepsilon''(\lambda_0)$ for water obtained by: I — author, $\Delta = [4]$, $\times = [6]$, C = [4] and data calculated from the Debye equation, ($\varepsilon = 80.4 - [6]$, $\varepsilon_n = 6.4 - [6]$; $1 - \tau = 0.754 \times 10^{-11} \text{ sec.}$, $\lambda_{max} = 1.43 \text{ cm. } 2 - \tau = 0.823 \times 10^{-11} \text{ sec.}$, $\lambda_{max} = 1.55 \text{ cm} = [7, 8]$, $3 - \tau = 0.886 \times 10^{-1} \text{ sec.}$, $\lambda_{max} = 1.83 \times 10^{-11} \text{ sec.}$

short circuit measurement given briefly in the Appendix. means that the thickness must be changed. The same thickness d_1 can be used for Suppose that for a given dielectric thickness d_i the condition (9) is not fulfilled. It

III. RESULTS

0.114 cm, when $d_0 = 0.003 \text{ cm}$. performed in the X-band with dielectric thicknesses d' = 0.074 cm and d'' =An experimental investigation of water with conductivity $\sigma = 5 \times 10^{-5} \Omega^{-1} \text{m}^{-1}$, is

and the data received from the Debye equations In Fig. 3 are shown the experimental results $\varepsilon'(\lambda_0)$ and $\varepsilon''(\lambda_0)$, the reference data

$$\varepsilon'(\omega) = \varepsilon_{\infty} + \frac{\varepsilon - \varepsilon_{\infty}}{(1 + \omega^2 \tau^2)}, \tag{14}$$

$$\varepsilon''(\omega) = \frac{\varepsilon - \varepsilon_{\omega}}{(1 + \omega^2 \tau^2)} \,. \tag{15}$$

In Eqs. (14) and (15) the following values are used: $\varepsilon_{\infty} = 6.4$ [6] (limiting high-frequency permittivity), $\varepsilon = 80.4$ [6] (limiting low-frequency permittivity) and $\tau = 0.823 \times 10^{-11}$ s [8, 7] relaxation time.

The measurement procedure is as follows:

- a) The shifts l_2' and l_2'' for two samples of thicknesses d' and d'', are measured in an open circuit, as shown in Fig. 1.
- b) The values of the function $f_2(x, y, \beta_0/\beta)$ (Fig. 2) are calculated by a computer using appropriate values of β_0/β , as shown in Table 1.
- c) The values of $-\text{tg}(\beta_0 l_2')/\beta_0 d'$ and $-\text{tg}(\beta_0 l_2'')/\beta_0 d''$ are calculated. The results in Fig. 2 refer to an investigation of water for d' = 0.074 cm, d'' = 0.114 cm and $\lambda_0 = 3$ cm.
- d) The values of $x' = \beta d'$ and $x'' = \beta d''$ are determined for the same values of $y = \alpha/\beta$ (Fig. 2). In this case there holds the relation x'/x'' = d'/d''.
- e) The values of the phase constant β are calculated from $\beta = x'/d'$ or $\beta = x''/d''$ and the value of the attenuation constant α is calculated from $\alpha = \beta y$. Values of ϵ' and ϵ'' can be obtained from Eqs (1) and (2), respectively.
- f) The error of ε' and tg δ can be derived from

$$\frac{\Delta \varepsilon'}{\varepsilon'} = 2 \frac{\Delta \beta}{\beta} = 2 \left[\frac{\Delta x}{x} + \frac{\Delta d}{d} \right], \tag{16}$$

$$\Delta \operatorname{tg} \delta = 2\Delta y = 2\Delta \frac{\alpha}{\beta} . \tag{17}$$

Eqs. (16) and (17) are obtained from eqs. (1), (2) and

$$\operatorname{tg} \delta = \frac{\varepsilon''}{\varepsilon'} = \frac{2y}{1 - y^2 + (\lambda_{\epsilon}/\lambda_{\epsilon})^2} \approx 2y \tag{18}$$

when $y^2 \leqslant 1$, where $\lambda_e = \lambda_g \beta/\beta_0$, where $\lambda_e = \lambda_g \beta/\beta_0$. The condition $y^2 \leqslant 1$ in Eq. (18) is fulfilled for $\varepsilon' \geqslant 50$ and $0 \leqslant \lg \delta \leqslant 1$. In Eqs. (16), (17) the values of Δx and Δy are obtained in the same way as x and y, using the function $f_2(x, y, \beta_0/\beta)$ and the experimental errors of Δl_2 and Δd by the expressions

$$-\operatorname{tg}\left[\beta_{o}(l_{2}^{\prime}\pm\Delta l_{2}^{\prime})\right]/\beta_{o}(d^{\prime}\pm\Delta d^{\prime})\tag{19}$$

$$-\operatorname{tg} \left[\beta_{0}(l_{2}'' \pm \Delta l_{2}'')\right]/\beta_{0}(d'' \pm \Delta d''). \tag{20}$$

IV. DISCUSSION

The analysis of experimental data for the values of ε' and tg δ of water shows an error of less than ± 7 %. The experimental curve $\varepsilon'(\lambda_0)$ in the X-band (Fig. 3) can be used to calculate the relaxation time with an uncertainty of ± 7 % if the values of ε_m and ε are known [4].

CONCLUSIONS

The possibility of determining $\varepsilon'(1 \le \varepsilon' \ne 95)$ and tg δ $(0 \le \text{tg } \delta \le 1)$ by the comparison of the experimental value $-\text{tg }(\beta_0 l_2)/\beta_0 d$ with the theoretical function $f_2(x, y, \beta_0/\beta)$ is described. The standing wave minimum shifts are measured for two dielectric thicknesses, investigated in an open circuit. The method is used to obtain ε' and tg δ of water in the X-band. The experimental data for $\varepsilon'(\lambda_0)$ can be used to calculate the relaxation time when the values of limiting high-frequency permittivity and low-frequency permittivity are known.

APPENDE

The method described in the paper can be applied to two dielectric thicknesses measured in a short circuit, or for one dielectric thickness measured in a short circuit.

For a short circuit measurement the necessary quantities x and y are obtained using the theoretical function $f_1(x, y, \beta_0/\beta)$,

$$\frac{\operatorname{tg}\left(\beta_{0}I_{1}\right)}{\beta_{0}d} = f_{1}(x, y, \beta_{0}/\beta), \qquad (21)$$

where $l_1(x, y, \beta_0/\beta)$ is given by [5],

$$l_1 = \frac{1}{2\beta_0} \arctan \frac{2(\beta_0/\beta)\varphi_1(x, y)}{1 - (\beta_0/\beta)^2\varphi_{11}(x, y)},$$
 (22)

$$\varphi_1(x, y) = \frac{y \sinh 2xy + \sin 2x}{(1+y^2)(\cosh 2xy + \cos 2x)},$$
 (23)

$$\phi_{11}(x, y) = \frac{\operatorname{ch} 2xy - \cos 2x}{(1+y^2)\left(\operatorname{ch} 2xy + \cos 2x\right)}.$$
 (24)

The theoretical function $f_1(x, y, \beta_0/\beta)$ is calculated by computer for values of β_0/β taken from Table 1.

When tg $\delta = 0$ (y = 0), the independence of $f_1(x, y, \beta_0/\beta)$ from the β_0/β can be proved from Eqs. (21—24). The independence of $f_1(x, y, \beta_0/\beta)$ from the values of

as in the case of the open circuit. In this case the following condition is valid β_0/β can be proved with the help of the function $\varphi_{11}(x, y)$ Eq. (24), in the same way

$$|f_1(x, y, \beta_0/\beta)| \leq 1$$
.

(25)

measured in a short and an open circuit. theoretical function $f_1(x, y, \beta_0/\beta)$ and $f_2(x, y, \beta_0/\beta)$ when only one thickness is It is also worth noting that the values of x and y can be obtained using the

because the functions $f_1(x, y, \beta_0/\beta)$ and $f_2(x, y, \beta_0/\beta)$ are shifted by $x \approx \pi/2$. Note that the conditions (9) and (25) are satisfied for different values of x

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